











**DAC1282, DAC1282A** 

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# DAC1282 Low Distortion Digital-to-Analog Converter for Seismic

## **Features**

- Single-Chip Test Signal Generator
- **Buffered Voltage Output**
- High Performance:
  - THD: -125 dB (G = 1/1 to 1/8)
  - SNR: 120 dB (413 Hz BW, G = 1/1)
- Analog and Digital Gain Control
- Output Frequency: 0.488 Hz to 250 Hz
- Sine, Pulse, and DC Modes
- Digital Data Input Mode
- Low On-Resistance Signal Switch
- Sync Input
- Power-Down Mode
- Analog Supply: 5 V or ±2.5 V
- Digital Supply: 1.8 V to 3.3 V
- Power: 38 mW
- Package: TSSOP-24
- Operating Range: -50°C to +125°C

# **Applications**

- **Energy Exploration**
- Seismic Monitoring Systems
- **High-Accuracy Instrumentation**

# 3 Description

The DAC1282 is a fully-integrated digital-to-analog converter (DAC) providing low distortion, digital synthesized voltage output suitable for testing of seismic equipment. The DAC1282 achieves very high performance in a small package with low power. Together, with the high-performance ADS1281 and ADS1282 analog-to-digital converters (ADCs), these devices create a measurement system that meets the exacting demands of seismic data acquisition equipment.

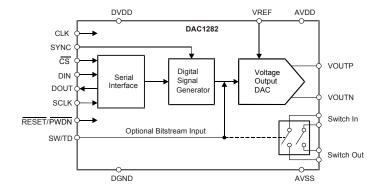
The DAC1282 integrates a digital signal generator, a DAC, and an output amplifier providing sine wave, dc, and pulse output voltages.

The output frequency is programmable from 0.5 Hz to 250 Hz and the magnitude is scaled by both analog and digital control. The analog gain is adjustable in 6dB steps and the digital gain in 0.5-dB steps. The analog gain settings match those of the ADS1282 for testing at all gains with high resolution.

The DAC1282 also provides pulse outputs. The pulse amplitude is user-programmed and then selected by the pin for precise timing. Custom output signals can be generated by applying an external bitstream pattern.

A signal switch can be used to connect the DAC output to sensors for THD and impulse testing. The switch timing is controlled by pin and by command.

A SYNC pin synchronizes the DAC output to the analog-to-digital converter (ADC) sample interval. A power-down input disables the device, reducing power consumption to microwatts.





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| 1 | Features 1  | 8.1 Overview 14                         |
|---|---|---|
| 2 | Applications 1  | 8.2 Feature Description                 |
| 3 | Description 1   | 8.3 Device Functional Modes30           |
| 4 | Revision History2   | 8.4 Programming                         |
| 5 | Device Comparison   | 8.5 Register Map                        |
| 6 | Pin Configuration and Functions                                   | 9 Application and Implementation 36     |
|   | _   | 9.1 Application Information             |
| 7 | Specifications  | 9.2 Typical Applications                |
|   | 7.1 Absolute Maximum Ratings                                      | 10 Device and Documentation Support 39  |
|   | 7.2 ESD Ratings   | 10.1 Community Resources                |
|   | 7.3 Thermal Information   | 10.2 Trademarks                         |
|   | 7.4 Electrical Characteristics                                    | 10.3 Electrostatic Discharge Caution    |
|   | 7.5 Timing Requirements: Serial Peripheral Interface (SPI) Timing | 10.4 Glossary                           |
|   | 7.6 Typical Characteristics 9                                     | 11 Mechanical, Packaging, and Orderable |
| 8 | Detailed Description 14   | Information 39                          |
|   | •   |   |

# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

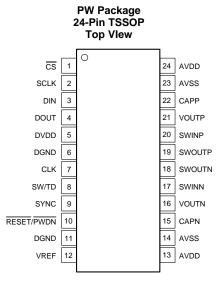
| Cha | inges from Revision A (September 2012) to Revision B        | Page |
|-----|---|------|
| • / | Added ADS1282A device to data sheet                         | 1    |
| Cha | anges from Original (December 2011) to Revision A           | Page |
| • ( | Updated Figure 16   | 10   |
| • / | Added last paragraph to Signal Output section               | 16   |
| • ( | Changed t <sub>CSHD</sub> minimum specification in Table 11 | 25   |
| • ( | Changed min, max, and unit columns in Table 12              | 26   |



# 5 Device Comparison

| DEVICE  | DESCRIPTION                  |
|---------|------------------------------|
| ADS1281 | High-resolution ADC          |
| ADS1282 | High-resolution ADC with PGA |
| REF5050 | Low-drift 5 V reference      |

# 6 Pin Configuration and Functions



# **Pin Functions**

| NAME         NO.           AVDD         13, 24         Analog supply         Analog positive power supply, reference ground           AVSS         14         Analog supply         Analog negative power supply, reference ground           AVSS         23         Analog supply         Analog negative power supply, reference ground           CAPN         15         Analog         External capacitor connected to VOUTN           CAPP         22         Analog         External capacitor connected to VOUTP           CS         1         Digital input         Serial port chip select           CLK         7         Digital input         Master clock 4.096 MHz           DGND         6         Ground         Key digital ground           DGND         11         Ground         Digital ground           DOUT         4         Digital input         Serial port data input           DOUT         4         Digital output         Serial port data output           DVDD         5         Digital supply         Digital power supply: 1.65 V to 3.6 V           RESET/PWDN         10         Digital input         Reset/power-down input           SCLK         2         Digital input         Switch positive lock           SW/TD         8 | PIN        |        | FUNCTION       | DECODINE                                       |  |
|---|------------|--------|----------------|--|--|
| AVSS 14 Analog supply Analog negative power supply, reference ground  AVSS 23 Analog supply Analog negative power supply  CAPN 15 Analog External capacitor connected to VOUTN  CAPP 22 Analog External capacitor connected to VOUTP  CS 1 Digital input Serial port chip select  CLK 7 Digital input Master clock 4.096 MHz  DGND 6 Ground Key digital ground  DIN 3 Digital input Serial port data input  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Serial port shift clock  SW/TD 8 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWOUTN 18 Analog I/O Switch negative output  SYNC 9 Digital input Negative output  Negative voltage output  Negative voltage output  Negative voltage output  Negative voltage output  Positive voltage output  | NAME       | NO.    | FUNCTION       | DESCRIPTION                                    |  |
| AVSS 23 Analog supply Analog negative power supply  CAPN 15 Analog External capacitor connected to VOUTN  CAPP 22 Analog External capacitor connected to VOUTP  Test 1 Digital input Serial port chip select  CLK 7 Digital input Master clock 4.096 MHz  DGND 6 Ground Key digital ground  DGND 11 Ground Digital input Serial port data input  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Serial port shift clock  SW/TD 8 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWOUTN 18 Analog I/O Switch positive output  SYNC 9 Digital input Negative voltage output  Negative voltage output  Positive voltage output  Positive voltage output  Positive voltage output  | AVDD       | 13, 24 | Analog supply  | Analog positive power supply                   |  |
| CAPN 15 Analog External capacitor connected to VOUTN  CAPP 22 Analog External capacitor connected to VOUTP  CS 1 Digital input Serial port chip select  CLK 7 Digital input Master clock 4.096 MHz  DGND 6 Ground Key digital ground  DGND 11 Ground Digital ground  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Serial port ata output  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Serial port shift clock  SWINN 17 Analog I/O Switch negative input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Negative voltage output  Negative voltage output  Negative voltage output  Negative voltage output  VOUTN 16 Analog output Positive voltage output  Positive voltage output   | AVSS       | 14     | Analog supply  | Analog negative power supply, reference ground |  |
| CAPP 22 Analog External capacitor connected to VOUTP  CS 1 Digital input Serial port chip select  CLK 7 Digital input Master clock 4.096 MHz  DGND 6 Ground Key digital ground  DGND 11 Ground Digital ground  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Serial port shift clock  SW/TD 8 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWOUTN 18 Analog I/O Switch positive output  SYNC 9 Digital input Negative voltage output  VOUTN 16 Analog output Positive voltage output  Positive voltage output  VOUTP 21 Analog output Positive voltage output  Positive voltage output  | AVSS       | 23     | Analog supply  | Analog negative power supply                   |  |
| CS 1 Digital input Serial port chip select  CLK 7 Digital input Master clock 4.096 MHz  DGND 6 Ground Key digital ground  DGND 11 Ground Digital ground  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Negative voltage output  Positive voltage output  | CAPN       | 15     | Analog         | External capacitor connected to VOUTN          |  |
| CLK 7 Digital input Master clock 4.096 MHz  DGND 6 Ground Key digital ground  DGND 11 Ground Digital ground  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWOUTN 18 Analog I/O Switch positive input  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  Negative voltage output   | CAPP       | 22     | Analog         | External capacitor connected to VOUTP          |  |
| DGND 6 Ground Key digital ground  DGND 111 Ground Digital ground  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output  Positive voltage output  | CS         | 1      | Digital input  | Serial port chip select                        |  |
| DGND 11 Ground Digital ground  DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch positive output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output  Positive voltage output   | CLK        | 7      | Digital input  | Master clock 4.096 MHz                         |  |
| DIN 3 Digital input Serial port data input  DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch positive output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output   | DGND       | 6      | Ground         | Key digital ground                             |  |
| DOUT 4 Digital output Serial port data output  DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output   | DGND       | 11     | Ground         | Digital ground                                 |  |
| DVDD 5 Digital supply Digital power supply: 1.65 V to 3.6 V  RESET/PWDN 10 Digital input Reset/power-down input  SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output  | DIN        | 3      | Digital input  | Serial port data input                         |  |
| RESET/PWDN   10   Digital input   Reset/power-down input  | DOUT       | 4      | Digital output | Serial port data output                        |  |
| SCLK 2 Digital input Serial port shift clock  SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output   | DVDD       | 5      | Digital supply | Digital power supply: 1.65 V to 3.6 V          |  |
| SW/TD 8 Digital input Switch control input or bitstream input  SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output   | RESET/PWDN | 10     | Digital input  | Reset/power-down input                         |  |
| SWINN 17 Analog I/O Switch negative input  SWINP 20 Analog I/O Switch positive input  SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output  | SCLK       | 2      | Digital input  | Serial port shift clock                        |  |
| SWINP 20 Analog I/O Switch positive input SWOUTN 18 Analog I/O Switch negative output SWOUTP 19 Analog I/O Switch positive output SYNC 9 Digital input Synchronize input VOUTN 16 Analog output Negative voltage output VOUTP 21 Analog output Positive voltage output  | SW/TD      | 8      | Digital input  | Switch control input or bitstream input        |  |
| SWOUTN 18 Analog I/O Switch negative output  SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output  | SWINN      | 17     | Analog I/O     | Switch negative input                          |  |
| SWOUTP 19 Analog I/O Switch positive output  SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output   | SWINP      | 20     | Analog I/O     | Switch positive input                          |  |
| SYNC 9 Digital input Synchronize input  VOUTN 16 Analog output Negative voltage output  VOUTP 21 Analog output Positive voltage output  | SWOUTN     | 18     | Analog I/O     | Switch negative output                         |  |
| VOUTN 16 Analog output Negative voltage output VOUTP 21 Analog output Positive voltage output   | SWOUTP     | 19     | Analog I/O     | Switch positive output                         |  |
| VOUTP 21 Analog output Positive voltage output  | SYNC       | 9      | Digital input  | Synchronize input                              |  |
| 110111111111111111111111111111111111111   | VOUTN      | 16     | Analog output  | Negative voltage output                        |  |
| VREF 12 Analog input Reference voltage input  | VOUTP      | 21     | Analog output  | Positive voltage output                        |  |
|   | VREF       | 12     | Analog input   | Reference voltage input                        |  |



# 7 Specifications

# 7.1 Absolute Maximum Ratings<sup>(1)</sup>

Over operating free-air temperature range, unless otherwise noted.

|                                       | MIN        | MAX        | UNIT |
|---------------------------------------|------------|------------|------|
| AVDD to AVSS                          | -0.3       | +5.5       | V    |
| AVSS to DGND                          | -2.8       | +0.3       | V    |
| DVDD to DGND                          | -0.3       | +3.6       | V    |
| Input current continuous              | -10        | +10        | mA   |
| Analog input/output voltage           | AVSS - 0.3 | AVDD + 0.3 | V    |
| Switch current                        | -60        | +60        | mA   |
| Digital input voltage to DGND         | -0.3       | DVDD + 0.3 | V    |
| Operating temperature range           | -50        | +125       | °C   |
| Storage temperature, T <sub>stg</sub> | -60        | +150       | °C   |

<sup>(1)</sup> Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

# 7.2 ESD Ratings

|                    |               |   | VALUE | UNIT |
|--------------------|---------------|---|-------|------|
| \/                 | Electrostatic | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)              | ±2000 |      |
| V <sub>(ESD)</sub> | discharge     | Charged-device model (CDM), per JEDEC specification JESD22-C101 (2) | ±500  | V    |

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 7.3 Thermal Information

|                      | THERMAL METRIC <sup>(1)</sup>                |         | LINUT |
|----------------------|--|---------|-------|
|                      | THERMAL METRIC                               | 24 PINS | UNIT  |
| $R_{\theta JA}$      | Junction-to-ambient thermal resistance       | 78.3    |       |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance    | 12.1    |       |
| $R_{\theta JB}$      | Junction-to-board thermal resistance         | 33.8    | °C/W  |
| $\Psi_{JT}$          | Junction-to-top characterization parameter   | 0.3     | *C/VV |
| ΨЈВ                  | Junction-to-board characterization parameter | 33.5    |       |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | N/A     |       |

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 7.4 Electrical Characteristics

Minimum and maximum specifications are at  $T_A = -40$ °C to +85°C. Typical specifications are at  $T_A = +25$ °C, AVDD = +2.5 V, AVSS = -2.5 V,  $f_{CLK} = 4.096$  MHz,  $V_{REF} = 5$  V, and DVDD = 3.3 V (unless otherwise noted). Refer to Figure 50. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.

|                   | PARAMETER                                |                  | TEST CONDITIONS        | MIN       | TYP                        | MAX                                    | UNIT                      |
|-------------------|--|------------------|------------------------|-----------|----------------------------|--|---------------------------|
| ANALO             | G OUTPUT (VOUTP, VOUTN)                  |                  |                        |           |                            | I                                      |                           |
|                   | Full-scale output voltage <sup>(1)</sup> |                  | Gain = 1/1 to 1/64     | ±         | V <sub>REF</sub> /2 × gain |  | V                         |
|                   | Output common-mode voltage               | e <sup>(2)</sup> |                        |           | -0.1                       |  | V                         |
|                   | Differential output impedance            | ,                |                        |           | 1.6                        |  | Ω                         |
| C <sub>LOAD</sub> | Capacitive load                          |                  |                        |           |                            | 2                                      | nF                        |
| R <sub>LOAD</sub> | Resistive load                           |                  |                        | 100       |                            |  | Ω                         |
|                   | Output current limit (3)                 |                  |                        |           | ±60                        |  | mA                        |
|                   |  |                  | T <sub>A</sub> = +25°C |           | 2                          |  |                           |
|                   | High-Z output leakage                    |                  | T <sub>A</sub> = +85°C |           | 50                         |  | nA                        |
| DC PER            | FORMANCE (Excluding Pulse Mode)          |                  |                        |           |                            |  |                           |
|                   | Gain error                               |                  | Gain = 1/1             |           | ±0.1%                      | ±0.75%                                 |                           |
|                   | Gain match                               |                  | Relative to gain = 1/1 |           | ±0.05%                     | ±0.5%                                  |                           |
|                   | Gain drift                               |                  |                        |           | 2                          |  | ppm/°C                    |
|                   | Offset                                   |                  | Gain = 1/1 to 1/64     |           | ±(7/gain) + 50             | ±(75/gain) +<br>300                    | ppm<br>FSR <sup>(4)</sup> |
|                   | Offset drift                             |                  |                        |           | 1.5                        |  | ppm<br>FSR/°C             |
| AC PER            | FORMANCE                                 |                  |                        |           |                            | <u>,</u>                               |                           |
|                   | ERFORMANCE                               |                  | Gain = 1/1             |           | -125                       | -118                                   | dB                        |
|                   |  |                  | Gain = 1/2, 1/4, 1/8   |           | -125                       |  | dB                        |
|                   |  | DAC1282          | Gain = 1/16            |           | -123                       |  | dB                        |
| THD               | Total harmonic distortion (5)            |                  | Gain = 1/32            |           | -115                       |  | dB                        |
|                   |  |                  | Gain = 1/64            |           | -111                       |  | dB                        |
|                   |  | DAC1282A         | Gain = 1/1             |           | -118                       | -106                                   | dB                        |
|                   |  | DAC1282A         | Gain = 1/4, 1/16       |           | -118                       | ±0.75%<br>±0.5%<br>±(75/gain) +<br>300 | dB                        |
|                   |  |                  | Gain = 1/1             | 116       | 120                        |  | dB                        |
|                   |  |                  | Gain = 1/2             |           | 119                        |  | dB                        |
|                   |  |                  | Gain = 1/4             |           | 117                        |  | dB                        |
| SNR               | Signal-to-noise ratio (6)                |                  | Gain = 1/8             |           | 114                        |  | dB                        |
|                   |  |                  | Gain = 1/16            |           | 110                        |  | dB                        |
|                   |  |                  | Gain = 1/32            |           | 106                        |  | dB                        |
|                   |  |                  | Gain = 1/64            |           | 100                        |  | dB                        |
|                   | Output frequency                         |                  |                        | 0.4883    |                            | 250                                    | Hz                        |
|                   | Digital gain                             |                  | 0.5-dB steps           | Full mute |                            | 0                                      | dB                        |
| PSR               | Downer ownels rejection                  | AVDD, AVSS       | 60 Hz ac gain 4/9      |           | 85                         |  | dB                        |
| PSK               | Power-supply rejection                   | DVDD             | 60-Hz ac, gain = 1/8   |           | 120                        |  | dB                        |

- (1) Full-scale differential output voltage:  $V_{OUT} = (VOUTP VOUTN) = \pm V_{REF}/2 \times Gain$ . Gain is the DAC analog gain.
- (2) Output common-mode voltage scales with analog supply voltage: V<sub>COM</sub> = 0.48 × (AVDD AVSS) + AVSS.
- (3) Sink or source current limit of VOUTP and VOUTN.
- (4) FSR full-scale range = V<sub>REF</sub> × gain.
- (5) THD = total harmonic distortion. THD is measured by the ADS1282, and is the sum of first nine harmonics using complementing gain. f<sub>OUT</sub> = 31.25 Hz, V<sub>OUT</sub> 0.5 dBFS, no load.
- (6) SNR = signal-to-noise ratio. SNR is measured by the ADS1282 over a 413-Hz bandwidth using complementing gain. f<sub>OUT</sub> = 31.25 Hz and V<sub>OUT</sub> 0.5 dBFS.



# **Electrical Characteristics (continued)**

Minimum and maximum specifications are at  $T_A = -40$ °C to +85°C. Typical specifications are at  $T_A = +25$ °C, AVDD = +2.5 V, AVSS = -2.5 V,  $f_{CLK}$  = 4.096 MHz,  $V_{REF}$  = 5 V, and DVDD = 3.3 V (unless otherwise noted). Refer to Figure 50. DAC1282A supports gains =  $\frac{1}{4}$   $\frac{1}{4}$  and  $\frac{1}{4}$  and

| PARAMETER   | TEST CONDITIONS                                       | MIN        | TYP                  | MAX         | UNIT              |
|---|---|------------|----------------------|-------------|-------------------|
| PULSE MODE  |   |            |                      | <u> </u>    |                   |
| Output levels                                     | 31 steps, approximate 3 dB per step                   | ±0.0195    |                      | ±2.5        | V                 |
| Gain error  |   |            | ±0.1%                | ±0.75%      |                   |
| Gain drift  |   |            | 3                    |             | ppm/°C            |
| Offset  |   |            | ±0.5                 | ±3          | mV                |
| Offset drift                                      |   |            | 3                    |             | μV/°C             |
| Output noise <sup>(7)</sup>                       |   |            | 1.5                  |             | $\mu V_{RMS}$     |
| Slew rate   |   |            | 5                    |             | V/µs              |
| Settling time                                     | 0.1% final value                                      |            | 25                   |             | μs                |
| DC MODE   | ,   |            |                      | -           |                   |
| Resolution  |   |            | 24                   |             | Bits              |
| Step response                                     |   |            | 100                  |             | μs                |
|   | Gain = 1/1  |            | 1.3                  |             | $\mu V_{RMS}$     |
|   | Gain = 1/2  |            | 1.4                  |             | $\mu V_{RMS}$     |
|   | Gain = 1/4  |            | 1.8                  |             | $\mu V_{RMS}$     |
| DC noise <sup>(8)</sup>                           | Gain = 1/8  |            | 2.7                  |             | $\mu V_{RMS}$     |
|   | Gain = 1/16   |            | 4.7                  |             | μV <sub>RMS</sub> |
|   | Gain = 1/32   |            | 8.5                  |             | μV <sub>RMS</sub> |
|   | Gain = 1/64   |            | 16                   |             | $\mu V_{RMS}$     |
| DIGITAL DATA MODE                                 |   |            |                      | 1           |                   |
| Data clock rate                                   |   |            | f <sub>CLK</sub> /16 |             | Hz                |
| Ones-density full-scale modulation                | +FS and -FS, respectively                             | 25%        | -                    | 75%         |                   |
| Signal bandwidth                                  | -3 dB   |            | 8.2                  |             | kHz               |
| REFERENCE VOLTAGE INPUT (V <sub>REF</sub> )       |   |            |                      | 1           |                   |
| Reference voltage, V <sub>REF</sub> = VREF – AVSS |   | 2.4        | 5                    | AVDD + 0.25 | V                 |
|   | Operating   |            | 220                  |             | kΩ                |
| Reference input impedance                         | Power-down  |            | 10                   |             | ΜΩ                |
| SIGNAL SWITCH                                     |   |            |                      | 1           |                   |
| Signal range                                      |   | AVSS       |                      | AVDD        | V                 |
| Current   | Continuous  |            |                      | ±50         | mA                |
| Differential on-resistance                        | V <sub>SWIN</sub> , V <sub>SWOUT</sub> = 0 V          |            | 2.8                  |             | Ω                 |
| Differential on-resistance flatness               | V <sub>SWIN</sub> , V <sub>SWOUT</sub> = AVDD to AVSS |            | 0.7                  |             | Ω                 |
| On-resistance match between outputs               | V <sub>SWIN</sub> , V <sub>SWOUT</sub> = 0 V          |            | 0.04                 |             | Ω                 |
|   | T <sub>A</sub> = +25°C                                |            | ±0.1                 |             |                   |
| Off-leakage current <sup>(9)</sup>                | T <sub>A</sub> = +85°C                                |            | ±5                   |             | nA                |
| Off-isolation <sup>(10)</sup>                     |   |            | 120                  |             | dB                |
| DIGITAL INPUT/OUTPUT (DVDD = 1.65 V to 3.6 V)     |   |            |                      |             |                   |
| V <sub>OH</sub>                                   | I <sub>OH</sub> = 1 mA                                | 0.8 × DVDD |                      |             | V                 |
| V <sub>OL</sub>                                   | I <sub>OL</sub> = 1 mA                                |            |                      | 0.2 × DVDD  | V                 |
| V <sub>IH</sub>                                   | 3.  | 0.8 × DVDD |                      | DVDD        | V                 |
| V <sub>IL</sub>                                   |   | DGND       |                      | 0.2 × DVDD  | V                 |
| Input hysteresis                                  |   |            | 0.5                  | 2           | V                 |
| Input leakage                                     |   |            |                      | ±10         | μA                |
|   |   | 1          | 4.096                | 4.225       | MHz               |

 $V_{OUT} = 0$  V. Pulse mode output noise is measured by the ADS1282, over a 413-Hz bandwidth using ADC gain = 1.  $V_{OUT} = 0$  V. DC noise is measured by the ADS1282, over a 413-Hz bandwidth using complementing gain. DC noise is referred to a 1.77-V full-scale ADC output. Divide output-referred noise by the ADC gain to yield input-referred noise. Switch input or output voltage = AVDD – 0.5 V to AVSS + 0.5 V.

<sup>(10)</sup> f = 31.25 Hz, 1.77  $V_{RMS}$ . Switch output loaded 2 x 10  $k\Omega$  to mid-supply range.



# **Electrical Characteristics (continued)**

Minimum and maximum specifications are at  $T_A = -40$ °C to +85°C. Typical specifications are at  $T_A = +25$ °C, AVDD = +2.5 V, AVSS = -2.5 V,  $f_{CLK}$  = 4.096 MHz,  $V_{REF}$  = 5 V, and DVDD = 3.3 V (unless otherwise noted). Refer to Figure 50. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.

| PARAMETER                   | TEST CONDITIONS                    | MIN         | TYP | MAX         | UNIT               |
|-----------------------------|------------------------------------|-------------|-----|-------------|--------------------|
| POWER SUPPLY                |                                    |             |     |             |                    |
| AVSS                        |                                    | -2.6        |     | 0           | V                  |
| AVDD                        |                                    | AVSS + 4.75 |     | AVSS + 5.25 | V                  |
| DVDD                        |                                    | 1.65        |     | 3.6         | V                  |
|                             | Gain = 1/1, V <sub>OUT</sub> = 0 V |             | 7.4 | 8.5         | mA <sup>(11)</sup> |
| AVDD, AVSS current          | Pulse mode, V <sub>OUT</sub> = 0 V |             | 7   |             | mA                 |
|                             | Shutdown                           |             | 1   | 10          | μΑ                 |
| DVDD                        | Operating                          |             | 180 | 300         | μΑ                 |
| DVDD current                | Shutdown <sup>(12)</sup>           |             | 1   | 10          | μΑ                 |
| Dawe                        | Operating                          |             | 38  | 44          | mW                 |
| Power                       | Shutdown <sup>(12)</sup>           |             | 10  | 85          | μW                 |
| TEMPERATURE RANGE           |                                    |             |     | ·           |                    |
| Specified temperature range |                                    | -40         |     | +85         | °C                 |
| Operating temperature range |                                    | -50         |     | +125        | °C                 |
| Storage temperature range   |                                    | -65         |     | +150        | °C                 |

<sup>(11)</sup> Analog supply current scales with gain as follows:

 $I_{AVDD}$  and  $I_{AVSS} = 0.016 \times V_{REF} \times (44 \times Gain + 1) + 3.8$  (mA). (12) Digital inputs stopped and maintained at  $V_{IH}$  or  $V_{IL}$  level.



# 7.5 Timing Requirements: Serial Peripheral Interface (SPI) Timing

At  $T_A = -40$ °C to +85°C and DVDD = 1.65 V to 3.6 V, unless otherwise noted.

|                    |  | MIN N | АХ              | UNIT             |
|--------------------|--|-------|-----------------|------------------|
| tcssc              | CS low to first SCLK: setup time <sup>(1)</sup>              | 30    |                 | ns               |
| t <sub>SCLK</sub>  | SCLK period  | 120   |                 | ns               |
| t <sub>SPWH</sub>  | SCLK pulse width: high                                       | 50    |                 | ns               |
|                    | SCLK pulse width: low <sup>(2)</sup>                         | 50    |                 | ns               |
| t <sub>SPWL</sub>  | SCLK pulse width: low (-)                                    |       | 2 <sup>18</sup> | t <sub>CLK</sub> |
| t <sub>DIST</sub>  | Valid DIN to SCLK high: setup time                           | 40    |                 | ns               |
| t <sub>DIHD</sub>  | Valid DIN to SCLK high: hold time                            | 20    |                 | ns               |
| t <sub>DOPD</sub>  | SCLK low to valid new DOUT: propagation delay <sup>(3)</sup> |       | 40              | ns               |
| t <sub>DOHD</sub>  | SCLK low to DOUT invalid: hold time                          |       | 0               | ns               |
| t <sub>CSDOD</sub> | CS low to DOUT driven: propagation delay <sup>(3)</sup>      |       | 40              | ns               |
| t <sub>CSDOZ</sub> | CS high to DOUT Hi-Z: propagation delay                      |       | 20              | ns               |
| t <sub>CSH</sub>   | CS high pulse  | 50    |                 | ns               |
| t <sub>SCCS</sub>  | Last SCLK falling edge to CS high                            | 0     |                 | ns               |

- $\overline{\text{CS}}$  can be tied low. Holding SCLK low longer than 2<sup>18</sup> f<sub>CLK</sub> cycles resets the SPI interface. DOUT load = 20 pF || 100 k $\Omega$  to DGND.

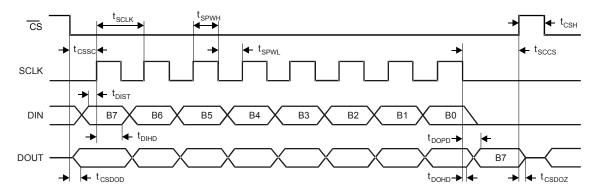
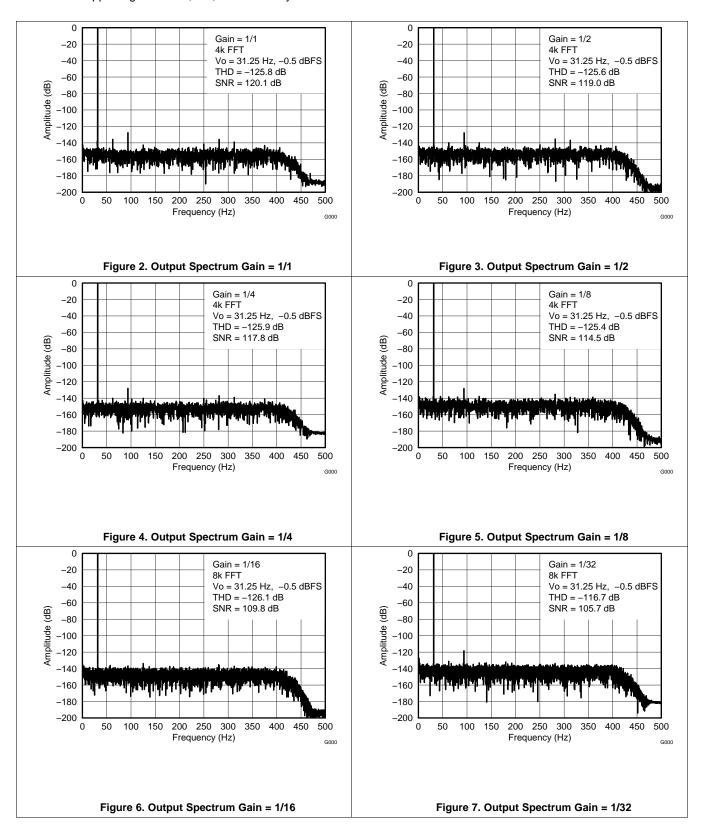


Figure 1. Serial Interface Timing



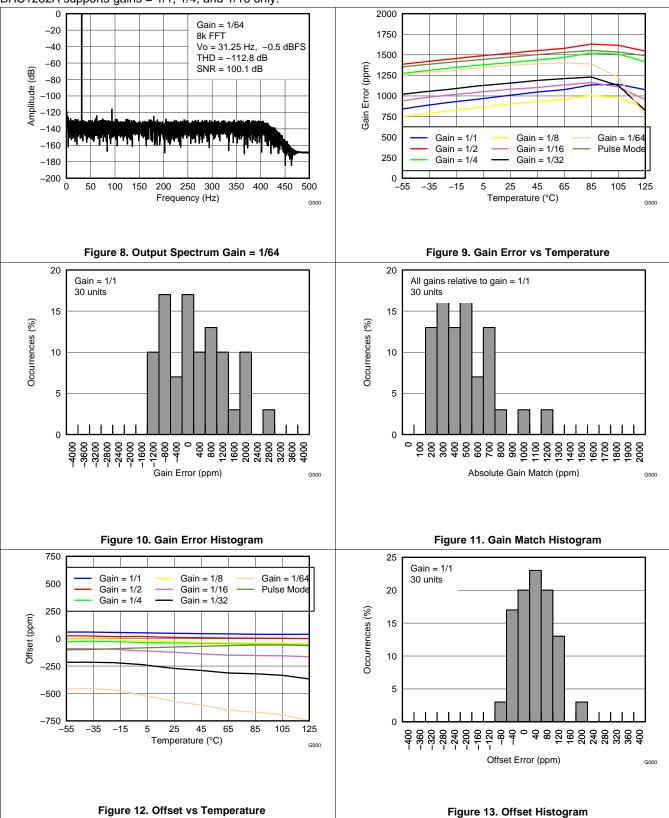
# 7.6 Typical Characteristics

At  $T_A$  = +25°C, AVDD = +2.5 V, AVSS = -2.5 V, DVDD = 3.3 V,  $f_{CLK}$  = 4.096 MHz, and  $V_{REF}$  = 5 V, unless otherwise noted. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.





At  $T_A$  = +25°C, AVDD = +2.5 V, AVSS = -2.5 V, DVDD = 3.3 V,  $f_{CLK}$  = 4.096 MHz, and  $V_{REF}$  = 5 V, unless otherwise noted. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.

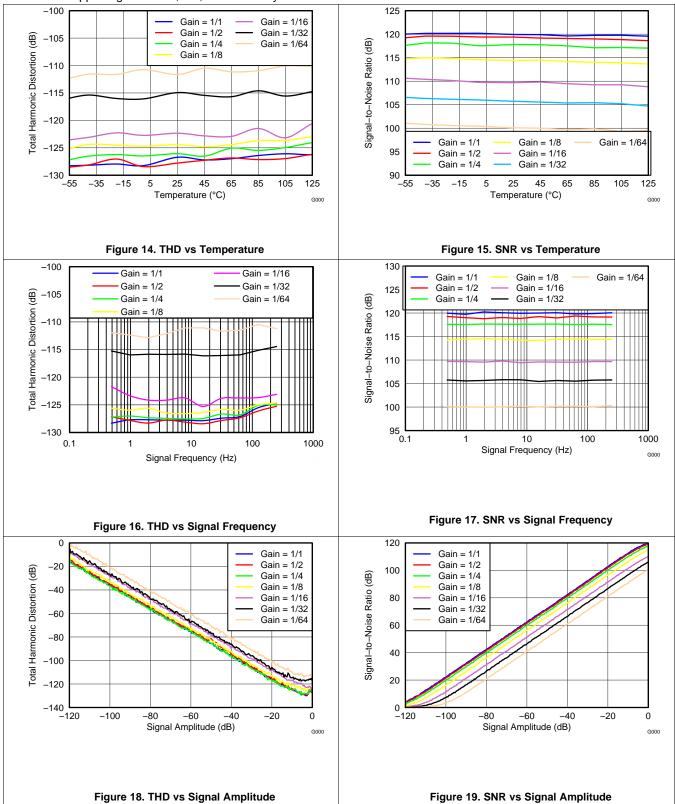


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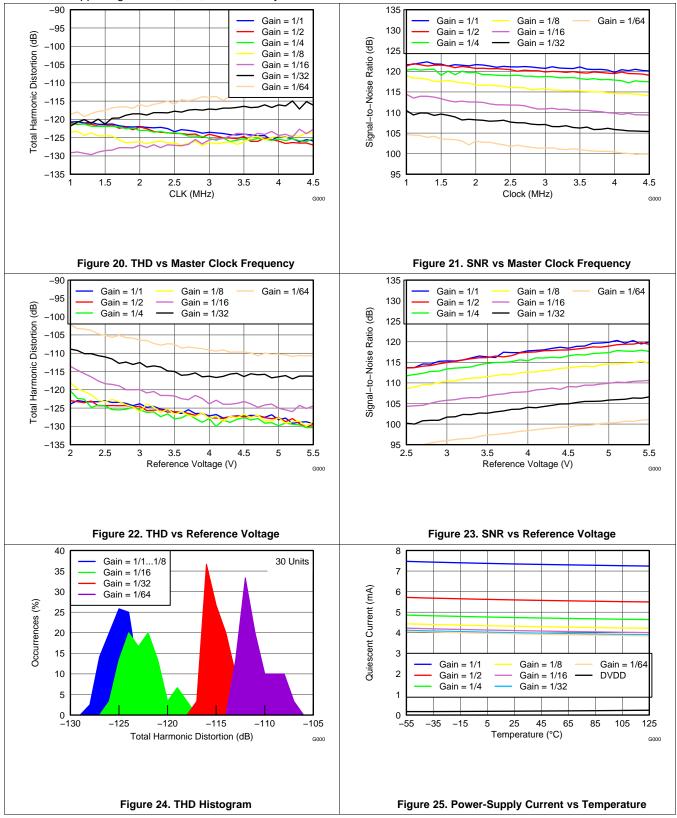


At  $T_A$  = +25°C, AVDD = +2.5 V, AVSS = -2.5 V, DVDD = 3.3 V,  $f_{CLK}$  = 4.096 MHz, and  $V_{REF}$  = 5 V, unless otherwise noted. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.





At  $T_A$  = +25°C, AVDD = +2.5 V, AVSS = -2.5 V, DVDD = 3.3 V,  $f_{CLK}$  = 4.096 MHz, and  $V_{REF}$  = 5 V, unless otherwise noted. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.

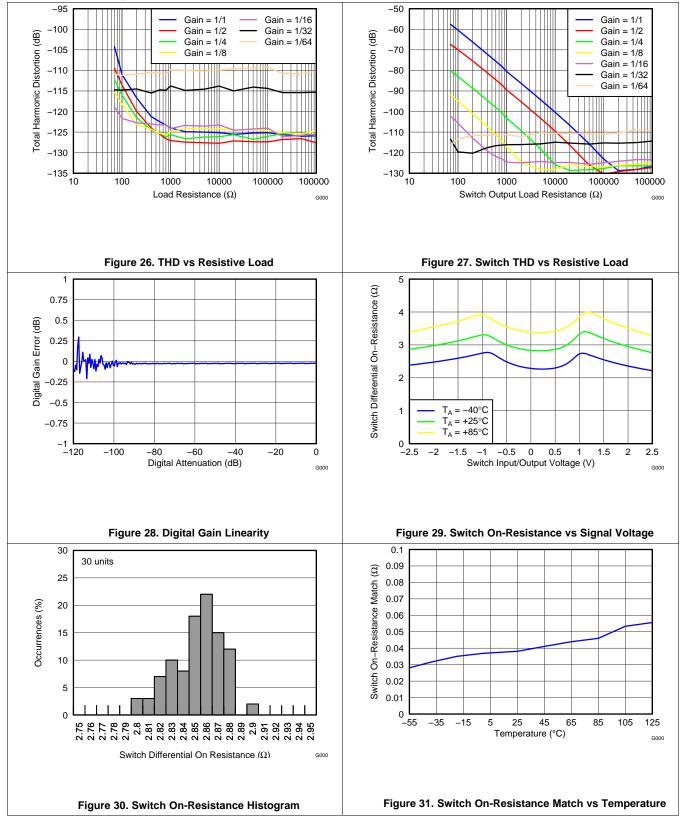


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At  $T_A$  = +25°C, AVDD = +2.5 V, AVSS = -2.5 V, DVDD = 3.3 V,  $f_{CLK}$  = 4.096 MHz, and  $V_{REF}$  = 5 V, unless otherwise noted. DAC1282A supports gains = 1/1, 1/4, and 1/16 only.





# 8 Detailed Description

#### 8.1 Overview

The DAC1282 is a single-chip, digital-to-analog converter (DAC) that self-generates low-distortion sine-wave and pulse-output signals for the demanding testing requirements of seismic recording equipment. Figure 32 shows the block diagram of the DAC1282.

The DAC1282A device is functionally equivalent to the DAC1282, except that the DAC1282A supports PGA gains of 1/1, 1/4, and 1/16 only. The DAC1282A also relaxes the THD specification of these gains. See the *Electrical Characteristics* section for more details.

The DAC1282 requires two supply voltages: analog and digital. The analog supply can be single 5 V or bipolar ±2.5 V. The digital supply range is 1.65 V to 3.6V. The output signal common-mode voltage is regulated to 100 mV below the midpoint of the analog power-supply voltage. An internal power-on reset (POR) circuit resets the DAC on power-up.

An SPI<sup>TM</sup>-compatible serial interface is used to access the DAC1282 registers for device configuration and control. The configuration registers can be read back by clocking the data out on the DOUT pin. The DAC1282 voltage output is fully differential and is taken out on the VOUTP/VOUTN pins. The CAPP/CAPN pins connect to external filter capacitors to reduce the output noise.

The reference input voltage sets the DAC1282 full-scale output. The DAC reference voltage is applied between the VREF and AVSS pins. The DAC is optimized to operate with a 5-V reference. The sine-wave generator is programmable by registers to set the sine frequency and amplitude. The frequency range is programmable from 0.4883 Hz to 250 Hz. The output level is controlled by both analog gain (in 6-dB steps), and digital gain (in 0.5-dB steps).

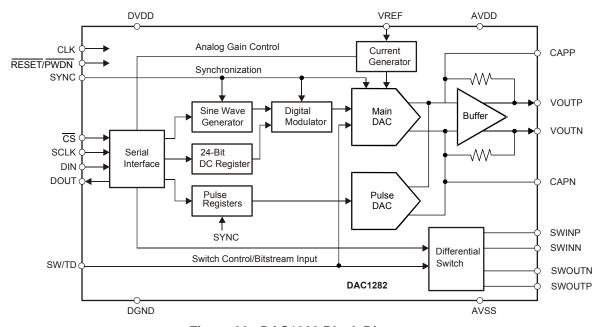


Figure 32. DAC1282 Block Diagram

The digital modulator takes the output from the sine-wave generator or the 24-bit dc register to generate the ones-density bitstream. The bitstream drives the main DAC. Optionally, ones-density data can be input to drive the DAC directly, bypasses the digital signal generator. The main DAC develops a differential output current that is converted to a differential output voltage by an internal current-to-voltage (I/V) amplifier. The output range is set by analog gain that scales the DAC current generator. The output amplifier provides current limit protection.

The dc mode is programmed by a 24-bit register and is used to provide a dc output. The dc mode also has programmable ranges controlled by the analog gain control.



## **Overview (continued)**

In Pulse mode, a fast-response, 5-bit pulse DAC is used to provide 31 preset dc levels. The levels span over the available output ranges. The pulse DAC is optimized to provide fast response with short output rise times. The pulse DAC is triggered by the SYNC pin for precision control of the pulse time.

The DAC1282 includes a low distortion differential output switch. The output switch can connect the DAC1282 output to sensors for THD and impulse testing. The switch is controlled by either pin or command, thus allowing precise switch timing.

The SYNC input synchronizes the output signal to a known time reference. In sine mode, SYNC resets the sine wave to the zero crossing. In Pulse mode, SYNC selects one of two user-programmed dc levels.

The RESET/PWDN pin powers down the device when low. When RESET/PWDN is released high, the DAC1282 is reset.

The SW/TD input is dual function. In digital data mode, the pin is the ones-density data input. In the other modes, SW/TD controls the opening/closing of the switch.

Figure 33 shows the main details of the main DAC. The main DAC provides the digital-to-analog conversion by filtering the ones-density digital data. In operation, the current generator establishes the range current that is mirrored to a multi-tap, current-steering filter stage. The current generator is controlled by the analog gain control register that scales the weight of the tap currents to one of seven ranges (0 dB to –36 dB).

The current-steering stage switches the tap currents to the positive or negative current summing nodes, as the digital input is sampled. A higher ones-density directs an increasing average current to one node than the other, thus increasing the differential current. The differential current is converted to differential voltage by the internal I/V converter stage. The common-mode current sources balance the current at the amplifier summing node.

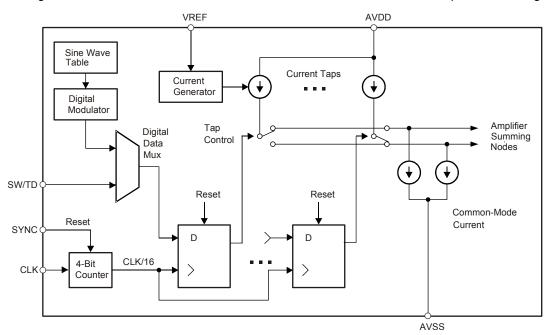


Figure 33. Main DAC Block Diagram

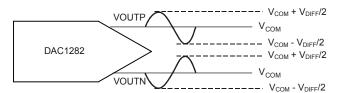


### 8.2 Feature Description

## 8.2.1 Signal Output (VOUTP, VOUTN)

As shown in Figure 34, the DAC provides a differential voltage ( $V_{DIFF} = VOUTP - VOUTN$ ) on pins VOUTP and VOUTN. The output common-mode voltage ( $V_{COM}$ ) is regulated to 100 mV below the midpoint of the analog supply (AVDD – AVSS).

Each signal output swings above and below the common-mode voltage. Best performance is realized when the DAC output is used differentially. In power-down mode, the outputs enter a high-impedance, 3-state mode.



NOTE:  $V_{DIFF} = VOUTP - VOUTN = \pm 2.5 \text{ V} \times \text{Gain} (V_{REF} = 5 \text{ V}).$  $V_{COM} = -0.1 \text{ V} (\pm 2.5 \text{-V supplies}) \text{ or } 2.4 \text{ V} (5 \text{-V supply}).$ 

Figure 34. DAC Output Signal

The DAC output buffer is rated to drive up to a 2-nF capacitive load (maximum) and a  $100-\Omega$  resistive load (minimum). However, degradation of THD performance results in resistive loads less than 1 k $\Omega$ , as shown in Figure 26

The internal digital modulator generates the signal to drive the DAC. The modulator shapes the in-band noise to high frequency and the frequency-shaped noise is present on the DAC output. However, the high frequency DAC output noise is rejected by the digital filter of the ADC and does not affect system performance.

The DAC sampling update noise is also present on the signal output. The sampling noise does not affect the ADC performance, but when testing the ADC near full-scale input, the noise can cause false indication of the ADC modulator overrange detection. The ADS1282 overrange output signal indication should be ignored when testing at or below the ADC full-scale input.



# **Feature Description (continued)**

#### 8.2.2 DAC Modes

The DAC1282 has four operational modes of: sine, dc, pulse, and external digital data input. These modes are programmed by the MODE[1:0] bits in the GANMOD register, as shown in Table 1.

**Table 1. DAC Modes** 

| MODE[1:0] BITS | DAC MODE     |
|----------------|--------------|
| 00             | Sine         |
| 01             | DC           |
| 10             | Digital data |
| 11             | Pulse        |

#### 8.2.2.1 Sine Mode

In sine mode, the DAC1282 provides a sine-wave output. An internal signal generator develops the sine-wave signal. The M[3:0], N[7:0], and FREQ register bits program the output frequency. The frequency range is programmable from 0.4883 Hz to 250 Hz, as shown in Equation 1.

Output Frequency (Hz) 
$$^{(1)} = \frac{250}{2^{FREQ}} \times \frac{M[3:0] + 1}{N[7:0] + 1}$$

where:

 $M[3:0] \le N[7:0]$ 

Table 2 lists values of registers M and N for selected output frequencies.

**Table 2. Register Output Frequencies** 

| SIGNAL FREQUENCY (Hz) <sup>(1)</sup> | M[3:0] REGISTER BITS | N[7:0] REGISTER BITS | FREQ BIT |
|--------------------------------------|----------------------|----------------------|----------|
| 0.48828125                           | 0000                 | 1111 1111            | 1        |
| 0.9765625                            | 0000                 | 1111 1111            | 0        |
| 1.953125                             | 0000                 | 0111 1111            | 0        |
| 3.90625                              | 0000                 | 0011 1111            | 0        |
| 7.8125                               | 0000                 | 0001 1111            | 0        |
| 15.625                               | 0000                 | 0000 1111            | 0        |
| 31.25                                | 0000                 | 0000 0111            | 0        |
| 50                                   | 0000                 | 0000 0100            | 0        |
| 55                                   | 1010                 | 0011 0001            | 0        |
| 60                                   | 0101                 | 0001 1000            | 0        |
| 62.5                                 | 0000                 | 0000 0011            | 0        |
| 100                                  | 1001                 | 0001 1000            | 0        |
| 125                                  | 0000                 | 0000 0001            | 0        |
| 250                                  | 0000                 | 0000 0000            | 0        |

<sup>(1)</sup>  $f_{CLK} = 4.096MHz$ . The signal frequency scales with  $f_{CLK}$ .



When the M or N registers are updated, the sine wave resets to the zero-crossing point. The sine wave can also be reset to the zero-crossing point by taking the SYNC pin high; see the SYNC section.

The amplitude of the sine-wave output is determined by analog and digital gains. The analog gain increments are 6 dB, from 0 dB to -36 dB, and are programmed by the GAIN[2:0] register bits. Table 3 lists the analog gains.

**Table 3. Analog Gain** 

| ANALOG GAIN (V/V) <sup>(1)</sup> | ANALOG GAIN (dB) <sup>(2)</sup> | DIFFERENTIAL RANGE (V) <sup>(3)</sup> | GAIN[2:0] REGISTER BITS |
|----------------------------------|---------------------------------|---------------------------------------|-------------------------|
| 1/1                              | 0                               | ±2.5                                  | 000                     |
| 1/2                              | -6                              | ±1.25                                 | 001                     |
| 1/4                              | -12                             | ±0.625                                | 010                     |
| 1/8                              | -18                             | ±0.312                                | 011                     |
| 1/16                             | -24                             | ±0.156                                | 100                     |
| 1/32                             | -30                             | ±0.078                                | 101                     |
| 1/64                             | -36                             | ±0.039                                | 110                     |

- (1) The DAC1282A supports analog gains of 1/1, 1/4, and 1/16 only.
- Relative to 1.77  $V_{RMS}$  full-scale.  $V_{REF} = 5 V$ , digital gain = 0 dB.
- (3)

The digital gain resolution is in 0.5-dB increments, from 0 dB to full mute and is programmed by the SINEG[7:0] register bits. Table 4 lists the digital gain setting. Equation 2 is the amplitude setting in sine mode.

Sine Amplitude (dB) = Analog Gain (dB) + Digital Gain (dB)

(2)

Best SNR, for a given signal level, is achieved by reducing the analog gain while maximizing the digital gain.

Table 4. Sine Mode Digital Gain

| SINE MODE DIGITAL GAIN (dB) | SINEG[7:0] REGISTER BITS |
|-----------------------------|--------------------------|
| 0                           | 0000 0000                |
| -0.5                        | 0000 0001                |
| -1.0                        | 0000 0010                |
| _                           | _                        |
| -119.5                      | 1110 1111                |
| Full mute                   | 1111 0000                |
| Full mute                   | 1111 xxxx                |
| Full mute                   | 1111 1111                |

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#### 8.2.2.2 DC Mode

The DAC1282 provides a dc output mode with 24-bit available resolution. The output level is determined by the analog gain and the 24-bit dc registers.

The GAIN[2:0] register bits set the analog gain (see Table 3). The DCG[23:0] register bits set the 24-bit level over the selected analog range. Table 5 lists the digital gain settings in dc mode.

| DIFFERENTIAL OUTPUT<br>VOLTAGE (V) <sup>(1)</sup> | DCG[23:0] REGISTER BITS |  |  |
|---|-------------------------|--|--|
| +2.5 x Gain                                       | 7FFFFh                  |  |  |
| +1.25 x Gain                                      | 3FFFFh                  |  |  |
| 0   | 0                       |  |  |
| −1.25 x Gain                                      | C00000h                 |  |  |
| –2.5 x Gain                                       | 800001h                 |  |  |

**Table 5. DC Mode Digital Gain Settings** 

#### 8.2.2.3 Pulse Mode

In pulse mode, a fast responding, 5-bit pulse DAC is used to generate the output. The pulse DAC is designed to approximate a linear-in-dB output function, allowing the generation of pulse test signals across all ranges. Two registers are used to preset the DAC output. The SYNC pin is used to select one of the two registers. When SYNC is low, the PULSA register value drives the DAC; when SYNC is high, the PULSB register value drives the DAC. The pulse registers can be programmed to yield differential outputs from -2.5 V to +2.5 V. Note that the pulse levels scale with  $V_{REF}$  and are independent of the analog gain settings. Table 6 lists the programmable range of the pulse A and pulse B registers.

| OUTPUT (V) <sup>(1)</sup> | OUTPUT (V) <sup>(1)</sup> PULSA[4:0], PULSB[4:0] OUTPUT (V) <sup>(1)</sup> PULSA[4:0], PULSB[4:0] |        |       |  |  |  |
|---------------------------|---|--------|-------|--|--|--|
| +2.50                     | 01111   | -0.020 | 11111 |  |  |  |
| +1.88                     | 01110   | -0.029 | 11110 |  |  |  |
| +1.25                     | 01101   | -0.039 | 11101 |  |  |  |
| +0.938                    | 01100   | -0.058 | 11100 |  |  |  |
| +0.625                    | 01011   | -0.078 | 11011 |  |  |  |
| +0.469                    | 01010   | -0.117 | 11010 |  |  |  |
| +0.312                    | 01001   | -0.156 | 11001 |  |  |  |
| +0.234                    | 01000   | -0.234 | 11000 |  |  |  |
| +0.156                    | 00111   | -0.312 | 10111 |  |  |  |
| +0.117                    | 00110   | -0.469 | 10110 |  |  |  |
| +0.078                    | 00101   | -0.625 | 10101 |  |  |  |
| +0.058                    | 00100   | -0.938 | 10100 |  |  |  |
| +0.039                    | 00011   | -1.25  | 10011 |  |  |  |
| +0.029                    | 00010   | -1.88  | 10010 |  |  |  |
| +0.020                    | 00001   | -2.50  | 10001 |  |  |  |
| 0                         | 00000   |        |       |  |  |  |

**Table 6. Pulse Register Values** 

Note that when pulse testing the ADC, the ADC digital filter time domain response has characteristic overshoot and ringing. As a result of the ADC filter overshoot, input levels close to ADC full scale may cause clipping of the ADC output code.

<sup>(1)</sup>  $V_{REF} = 5 \text{ V}$ . Ideal output voltage excluding gain, offset, linearity and noise errors..

<sup>(1)</sup> V<sub>REF</sub> = 5 V. Ideal pulse mode differential output, values are rounded and exclude noise, offset, gain, and linearity errors.



### 8.2.2.4 Digital Data Mode

In digital data mode, the DAC internal signal generator is bypassed and the DAC is driven instead by applying a bitstream input. Arbitrary DAC output waveforms can be generated by application of custom digital data patterns. The data format in this mode is ones-density modulated input at CLK/16 data rate (256 kHz). The input is applied to the SW/TD input pin. The DAC1282 output in digital data mode is defined in Equation 3.

Digital Data Mode Differential Output = VOUTP - VOUTN =  $V_{REF}/2 \times Gain \times (TD - 50\%)/25\%$  where:

V<sub>RFF</sub> is 5-V nominal,

Gain is the analog gain (1/1 to 1/64),

TD is the bitstream ones-density from 25% to 75%.

(3)

The DAC1282 filters the digital data (bitstream) input providing a voltage output proportional to the bitstream ones-density. The GAIN[2:0] register sets the analog gain in 6-dB steps, from 0 dB to -36 dB (1/1 to 1/64); see the SYNC section for the external timing requirements. Table 7 lists several values of the external bitstream input.

**Table 7. External Bitstream Input** 

| ONES-DENSITY BITSTREAM (%) | VOUTP – VOUTN (V) <sup>(1)</sup> |
|----------------------------|----------------------------------|
| 25                         | −2.5 x Gain                      |
| 37.5                       | −1.25 × Gain                     |
| 50                         | 0                                |
| 62.5                       | +1.25 × Gain                     |
| 75                         | +2.5 x Gain                      |

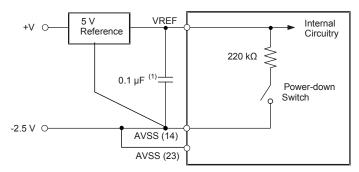
(1)  $V_{REF} = 5 \text{ V}$ . Gain is the analog gain, programmable from 1/1 to 1/64 (0 dB to -36 dB).



## 8.2.3 Reference Voltage (V<sub>REF</sub>)

The DAC1282 requires an external reference for operation. Although reference voltage as low as 2.5 V can be used, best SNR is achieved with a 5-V reference. The reference input is defined as the voltage difference between VREF and AVSS (that is,  $V_{REF} = VREF - AVSS$ ). The DAC1282 output scales with  $V_{REF}$ ; consequently, reference noise or drift appears on the DAC output. Excessive reference noise may lead to degraded SNR. A low-drift and low-noise reference is recommended.

Connect the external reference ground pin directly to the AVSS pins using a star connector to AVSS pin 14. Star connection minimizes the possibility of power-supply crosstalk. Also, connect a 0.1-µF capacitor close to the VREF and AVSS terminals to reduce noise susceptibility. Figure 35 shows the reference connection. The reference input impedance is 220 k $\Omega$ . In power-down the switch is off, resulting in very high input impedance. For single-supply applications, connect AVSS to a clean analog ground point.



(1) Recommended bypass capacitor.

Figure 35. Reference Input Connection

## 8.2.4 Output Filter (CAPP, CAPN)

The CAPP and CAPN pins are the connections for two external capacitors, one capacitor connects to CAPP and VOUTP and the other capacitor connects to CAPN and VOUTN. The capacitors are required to filter the DAC sampling noise. The capacitor values are 1 nF; capacitors with low voltage coefficients should be used (COG ceramic or film).

As seen in Figure 36, the external capacitors form an analog low-pass filter with the internal feedback resistors. After step changes to the data in the sine, dc, and digital data modes, the settling of the DAC and the analog filter is 100-us typical, as shown in Figure 46. In pulse mode, the filter is internally disabled, yielding shorter settling time.

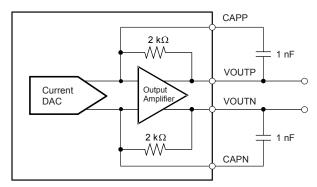


Figure 36. Output Filter

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## 8.2.5 Output Switch (SWINP, SWINN, SWOUTP, SWOUTN)

The DAC1282 has an integrated output switch. The switch can be used to route the DAC output signal to a sensor for pulse, THD, and common-mode testing. The switch has low on-resistance and matched elements to minimize signal distortion. The switch input voltage range extends to the analog power supply.

The switch is controlled by three register bits, SW[2:0], and is also controlled by the SW/TD input pin. The switch integrates break-before-make operation when the register or the SW/TD input control is changed. The SW/TD input can be used to force the switch open for precise timing control of sensor impulse testing; see the Switch Control/DAC Data Input (SW/TD) section. Figure 37 and Table 8 describe the switch operation.

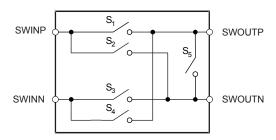


Figure 37. DAC1282 Signal Switch

Note that when the DAC is in power-down mode, the switch is forced open.

As shown in Figure 29, the switch on-resistance varies with the switch signal level. When the switch is used to route the signal and a resistive load is connected to the switch output, the switch on-resistance variations interact with the load resistance and cause the THD to degrade. Figure 27 illustrates the dependence of THD versus switch load resistance. The dependence of THD data was taken with a full-scale signal.

**Table 8. Switch Connections** 

| DESCRIPTION           | PIN CONNECTIONS                     | SWITCHES CLOSED | SW[2:0] REGISTER BITS |
|-----------------------|-------------------------------------|-----------------|-----------------------|
| Open (default)        | Open                                | None            | 000                   |
| Differential          | SWINP to SWOUTP and SWINN to SWOUTN | S1, S3          | 001                   |
| Differential reverse  | SWINP to SWOUTN and SWINN to SWOUTP | S2, S4          | 010                   |
| Common-mode positive  | SWINP to SWOUTP and SWOUTN          | S1, S2          | 011                   |
| Common-mode negative  | SWINN to SWOUTP and SWOUTN          | S3, S4          | 100                   |
| Single-ended positive | SWINP to SWOUTP                     | S1              | 101                   |
| Single-ended negative | SWINN to SWOUTN                     | S3              | 110                   |
| Output short          | SWOUTP to SWOUTN                    | <b>S</b> 5      | 111                   |



### 8.2.6 Clock Input (CLK)

The CLK pin is the master clock input to the DAC1282, nominally 4.096 MHz. As with any high-performance data converter, a high-quality clock source is essential. A crystal oscillator or low-jitter PLL clock source is recommended. Make sure to avoid ringing on the input by keeping the trace short and source-terminating (typically 50  $\Omega$ ). See the CLK specifications shown in Figure 38 and Table 9.

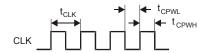


Figure 38. CLK Timing Requirements

Table 9. Requirements for Figure 38

| SYMBOL               | DESCRIPTION                 | MIN | MAX  | UNIT |
|----------------------|-----------------------------|-----|------|------|
| t <sub>CLK</sub>     | CLK period                  | 235 | 1000 | ns   |
| t <sub>CPWH, L</sub> | CLK pulse width high or low | 95  | 900  | ns   |

### 8.2.7 Switch Control/External Digital Input (SW/TD)

SW/TD is a multi-function digital input pin. The SW/TD function depends on the mode of operation.

#### 8.2.7.1 SW Function

In sine, dc, and pulse mode, SW/TD controls the output switch. When SW/TD is low, all switches are forced open, overriding the switch register setting (SW[2:0]). When SW/TD is high, the switch is transparent to the value of register setting. In power-down mode, the switch is forced open.

### 8.2.7.2 TD Function

In digital input mode, SW/TD is the signal input used to drive the DAC. The data input are modulated by onesdensity and are clocked in by the master clock (CLK). When the ones-density is 75% (that is, on average, three out of four bits are '1'), the differential output voltage is at the positive maximum value. When the ones-density is 25% (that is, on average, three out of four bits are '0'), the differential output voltage is at the negative maximum value. When the ones-density is 50% (on average, an equal number of '0's and '1's), the differential output is zero.

SW/TD is sampled by the DAC1282 at the rate of CLK/16. Therefore, the sampling can have ±8 CLK periods of uncertainty. SYNC can be used to eliminate the uncertainty by synchronizing the phase of SW/TD to the desired CLK cycle. Synchronizing the digital input results in a consistent phase of the output signal; see the SYNC section.

The output range is set by the analog gain bits, GAIN[2:0]; see Table 3. Equation 3 describes the DAC output versus the bitstream input ones-density. Make sure to avoid ringing on the input by keeping the trace short. In some cases, source-terminating resistors may be necessary (20  $\Omega$  to 50  $\Omega$ ).



#### 8.2.8 SYNC

SYNC is a digital input used to synchronize the DAC1282 output.

In the digital data mode, the DAC input is a ones-density bitstream. In this mode, the SYNC pin synchronizes the sampling of SW/TD digital data to the desired master clock cycle (CLK). When SYNC is low or high, the DAC operates normally. When SYNC is taken from low to high, the DAC output is reset to zero and the sample instant of SW/TD is reset to the eighth rising CLK edge that follows. The SW/TD is then regularly sampled on subsequent 16 CLK intervals. After synchronization, the DAC output is not settled and achieves full settling 400 CLK periods later, as shown in Figure 39.

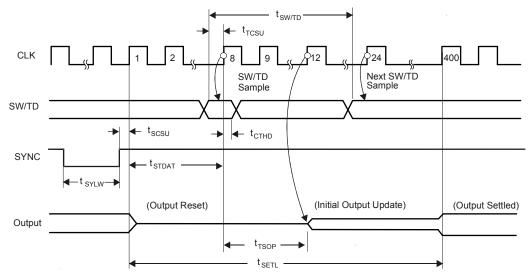


Figure 39. Digital Data Mode Synchronization

Table 10. Timing Characteristics for Figure 39<sup>(1)</sup>

| SYMBOL             | DESCRIPTION                                   | MIN | TYP | UNIT             |
|--------------------|---|-----|-----|------------------|
| t <sub>SCSU</sub>  | SYNC high to CLK high setup time              | 30  |     | ns               |
| t <sub>TCSU</sub>  | SW/TD to CLK high setup time                  | 30  |     | ns               |
| t <sub>CTHD</sub>  | CLK high to SW/TD hold time                   | 10  |     | ns               |
| t <sub>SYLW</sub>  | SYNC low pulse width                          | 2   |     | t <sub>CLK</sub> |
| t <sub>STDAT</sub> | CLK high after SYNC high to SW/TD sample time |     | 8   | t <sub>CLK</sub> |
| t <sub>TSOP</sub>  | SW/TD sample to output update                 |     | 4   | t <sub>CLK</sub> |
| t <sub>SW/TD</sub> | SW/TD period                                  |     | 16  | t <sub>CLK</sub> |
| t <sub>SETL</sub>  | SYNC high to fully-settled output             |     | 400 | t <sub>CLK</sub> |

(1) DVDD = 1.65 V to 3.6 V.



In sine mode, the SYNC rising edge resets the DAC output to differential 0 V (sine-wave zero-crossing point). When SYNC is high or low, the output is unaffected. When SYNC is taken from low to high, the output resets on the following CLK rising edge. SYNC must be pulsed low for a minimum of 2 CLK cycles. The SYNC input can be applied simultaneous to the DAC and the ADS1282 (ADC in pulse-sync mode).

To synchronize the DAC, observe SYNC to the CLK timing requirements shown in Figure 40. That is, the SYNC rising edge should be applied before the set-up time or after the hold time specifications. If the SYNC timing requirement is not met, the DAC may synchronize with one clock cycle timing error.

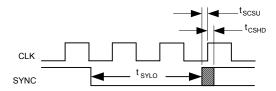


Figure 40. Sine Mode Synchronization

Table 11. Timing Characteristics for Figure 40<sup>(1)</sup>

| SYMBOL            | DESCRIPTION                                    | MIN | UNIT             |
|-------------------|--|-----|------------------|
| t <sub>SYLO</sub> | SYNC pulse width low                           | 2   | t <sub>CLK</sub> |
| tscsu             | SYNC rising edge to CLK rising edge setup time | 30  | ns               |
| t <sub>CSHD</sub> | CLK rising edge to SYNC rising edge hold time  | 40  | ns               |

(1) DVDD = 1.65 V to 3.6 V.

In pulse mode, the SYNC pin selects one of two pre-programmed pulse levels. The pulse levels are programmable from +2.5 V to -2.5 V in approximately 3-dB steps by pulse level registers PULSA and PULSB. When SYNC is low, the value of the PULSA register drives the DAC; when SYNC is high, the value of the PULSB register is the code of the DAC, as shown in Figure 41. When the SYNC pin is changed, the DAC output updates immediately to the new code.

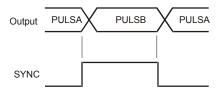


Figure 41. Sync Operation in Pulse Mode



### 8.2.9 RESET/PWDN

The RESET/PWDN is a digital input used to power-down and reset the DAC1282. To power-down the DAC, take the pin low. In power-down mode, the power consumption is reduced to a device leakage level (see the Electrical Characteristics table). The signal output and digital pin DOUT enters 3-state and the output switch is driven off. Note that the digital inputs must remain defined as either logic low or logic high; do not float the inputs. Disable the CLK input to minimize leakage. To exit the power-down state, take the pin high. The DAC1282 is reset after power-down mode is exited.

The DAC1282 is reset by taking the  $\overline{RESET/PWDN}$  pin low for a minimum of two f<sub>CLK</sub> cycles and is then taken back high. The DAC1282 is held in reset for 2 f<sub>CLK</sub> cycles; after this time, DAC communications may begin, as shown in Figure 42 and Table 12.

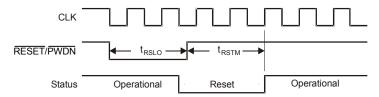


Figure 42. DAC RESET/PWDN

Table 12. Timing Characteristics for Figure 42

| SYMBOL            | DESCRIPTION                               | MIN MAX | UNIT |
|-------------------|---|---------|------|
| t <sub>RSLO</sub> | PWDN/RESET pulse width low for power-down | 500     | ns   |
| t <sub>RSTM</sub> | PWDN/RESET high to begin operation        | 500     | ns   |

## 8.2.10 AVDD, AVSS, and DVDD Power Supplies

The DAC1282 has two power supplies: analog and digital. The analog supply (AVDD, AVSS) is 5 V and can either be single 5 V or dual (±2.5 V). The analog supply should be clean and free from noise and ripple. The DAC1282 regulates the output common-mode voltage to 0.1 V below the mid-point of the analog supply. Because the analog supply pins draw signal-dependent current and AVSS (pin 14) is internally shared with the reference input low, trace resistance between AVSS (pin 14) and the AVSS power supply should be minimized or degraded performance may result. Therefore, connect the external reference ground terminal close to the device AVSS terminal using a star connection. This configuration helps to minimize power-supply coupling to the reference input.

DVDD is the digital supply used to power both the internal digital and the device I/O pins. The allowable range of DVDD is 1.65 V to 3.6 V.

The power supplies can be sequenced on or off in any order, but the analog or digital inputs should never exceed AVDD or AVSS, or DVDD, respectively. In such an event, the internal ESD protection diodes may begin to conduct. The input current must always be limited as specified in the Absolute Maximum Ratings table.



At power-on, when the latter of DVDD exceeds approximately 1.3 V, or the difference of AVDD – AVSS exceeds approximately 1.4 V, an internal power-on reset (POR) occurs. During POR, the device is held in a reset condition for a period of  $2^{16}$  f<sub>CLK</sub> periods as shown in Figure 43. During this time, the DAC1282 output is held at 0 V, differential. SPI communications are not possible during this time. After the reset time elapses, the default settings are loaded: 31.25 Hz, 28 mV<sub>RMS</sub> amplitude, and output switch off. SPI communications can then be started.

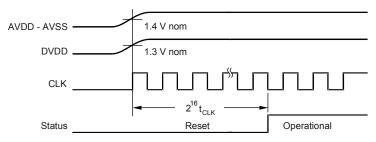


Figure 43. Power-On Sequence

### 8.2.10.1 Power Consumption

The power consumed by the DAC1282 depends on the analog gain. Table 13 shows the DAC power consumption.

| ANALOG GAIN | POWER (mW) <sup>(1)</sup> |
|-------------|---------------------------|
| 1/1         | 38                        |
| 1/2         | 28                        |
| 1/4         | 23                        |
| 1/8         | 21                        |
| 1/16        | 20                        |
| 1/32        | 20                        |
| 1/64        | 20                        |

**Table 13. Power Consumption** 

### 8.2.10.2 Offset and Gain Error

The DAC1282 features a low offset error (±7/Gain + 50 ppm FS typical) and low gain error (0.1 % typical). Offset and gain drift are also very low for the DAC1282. Drift is calculated using the box calculation method of Equation 4:

Drift Calculation = (Max - Min) / Temperature Range (ppm/°C)

Where:

Max and Min are, respectively, the maximum and minimum offset and gain errors (in ppm) recorded over the specified temperature range of -40°C to +85°C. (4)

Gain match is the gain error of Gain = 1/1 relative to all analog gains.

#### 8.2.10.3 Signal-to-Noise Ratio (SNR)

The DAC1282 achieves excellent signal-to-noise ratio (SNR) performance. The SNR data are obtained using the DAC circuit of Figure 50 and data captured by the ADS1282.

SNR is measured with a signal level of -0.5 dBFS and a 31.25-Hz test frequency, then taking the fast fourier transform (FFT) of 4096 data points from the ADS1282, using complementing gains. The noise power is calculated over the bandwidth of 413 Hz (1-ms sample period). The dc, fundamental, and harmonic bins are removed to calculate the SNR. The SNR measurement represents the combination of the ADS1282 SNR and the SNR of the DAC1282.

<sup>(1)</sup> Typical power consumption with  $V_{REF}$  = 5 V and  $V_{OUT}$  = 0 V. Excludes pulse mode.



#### 8.2.10.4 DC Noise

DC noise data are obtained using the DAC circuit of Figure 50 with data captured by the ADS1282. The noise is measured in dc mode with the output voltage set to 0 V differential. The ADC gain is set to the complement of the DAC gain for each output range. The noise is the standard deviation of 4096-point ADC acquisition record (RMS noise, referred-to-output).

## 8.2.10.5 Total Harmonic Distortion (THD)

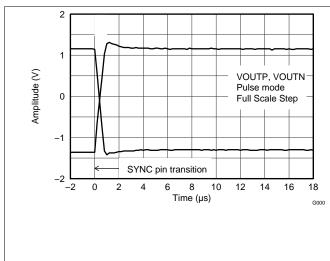
The DAC1282 achieves excellent THD performance. The THD data are obtained using the DAC circuit of Figure 50 and captured by the ADS1282. The ADC gain is set to the complement of the DAC gain for each output range.

THD is measured with a -0.5-dBFS output signal level and a 31.25-Hz test frequency, then taking the FFT of the 4096-point ADC acquisition record. The ADC data points are increased to 16,384 for gains of 1/16, 1/32, and 1/64 for improved rendition of harmonics as a result of the higher noise floor. The THD measurement represents the combination of the ADS1282 THD and the DAC1282 THD.

## 8.2.11 Step Response

The step response of the DAC depends on the mode. In pulse mode, the DAC disables the external analog filter formed by capacitors CAPP, CAPN. Disabling the analog filter in conjunction with the fast response pulse DAC results in noticeably faster rise time and shorter settling time. Note that additional filter components in the signal path may also affect the response time.

Figure 44 shows the pulse mode step response after the SYNC pin transition. Figure 45 shows the pulse mode detail settling to 0.1% of final value after the SYNC pin transition.



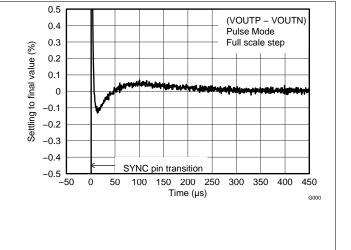


Figure 44. Pulse Mode Step Response

Figure 45. Pulse-Mode, Step-Response Detail

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Figure 46 shows the step response time of the dc mode. The step response of sine and digital data mode have similar settling times. Note that additional filter components in the signal path may also affect the response time.

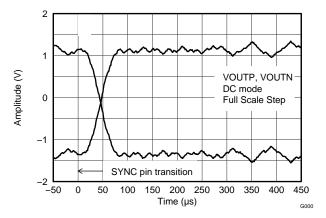
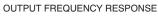


Figure 46. DC-Mode Step Response

## 8.2.12 Frequency Response

The DAC internal signal generator is capable of output signal frequencies from 0.489 Hz to 250 Hz. Frequencies outside of this range are also possible by driving the DAC directly with an external digital input (bitstream). However, the DAC low-pass filters the digital input and results in a sinx/x frequency response. The –3 dB signal bandwidth of the DAC filter is 8.2 kHz. Figure 47 illustrates the DAC1282 frequency response. Note that high-order noise-shaped digital inputs may limit the useable frequency range as a result of rising noise.



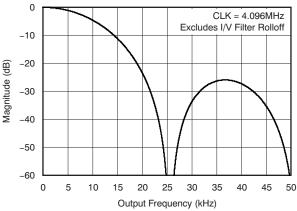


Figure 47. DAC Frequency Response

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#### 8.3 Device Functional Modes

#### 8.3.1 Serial Interface

Configuration of the DAC is by an SPI-compatible serial interface consisting of four signals:  $\overline{CS}$ , SCLK, DIN, and DOUT; or the interface can consist of three signals in which case  $\overline{CS}$  may be tied low. Tying  $\overline{CS}$  low permanently selects the device and DOUT remains a driven output. The interface is used to read and write registers and also is used to send a DAC reset command.

#### 8.3.1.1 Serial Communications

DAC1282 communication occurs by clocking register data into the device (on DIN) and reading back register data (on DOUT). The SCLK input is used to clock data into and out of the device. Data are input on the serial clock (SCLK) rising edge and output on the SCLK falling edge. The communication protocol is half-duplex (that is, data are transmitted to and from the device one direction at a time).

Communications to the device occur on 8-bit boundaries. If an unintentional SCLK transition should occur (such as is possible from a noise spike), the DAC1282 command decoder can be out-of-sync and the serial port may not respond properly. The serial port may reset in one of the following ways:

- 1. Take CS high to reset the interface
- 2. Hold SCLK inactive (low state) for 2<sup>18</sup> f<sub>CLK</sub> cycles to automatically reset the interface (see the *SPI Timeout* section)
- 3. Take RESET/PWDN low then back high to reset the device and the interface
- 4. Cycle the power supplies for a power-on reset (POR)

## 8.3.1.2 Chip Select (CS)

CS (chip select) selects the DAC1282 for communication. To select the device, pull CS low. CS must remain low for the duration of the command sequence. When CS is taken high, the serial interface is reset, input commands are ignored, and DOUT enters a high-impedance state.

#### 8.3.1.3 Serial Clock (SCLK)

The serial clock (SCLK) is a Schmitt-triggered input used to clock data into and out of the DAC1282. SCLK can be idled high or low. If SCLK is idled low, the SPI timeout feature is active. If SCLK is idled high, the SPI timeout feature is disabled.

Despite the built-in Schmitt-trigger, keep SCLK as clean as possible to prevent glitches from accidently shifting the data. Series-terminated printed circuit board (PCB) traces often help to reduce ringing and overshoot (series termination resistance is approximately 20  $\Omega$  to 50  $\Omega$ ). If SCLK is held low for  $2^{18}$  f<sub>CLK</sub> periods, the serial interface is reset. The timeout feature can be used to automatically recover the SPI port in the event of a noise glitch. Avoid starting new commands after this time interval to prevent an unexpected serial port reset at the next command instant.

## 8.3.1.4 Data Input (DIN)

DIN is the data input pin used to send data to the DAC. The DAC1282 latches DIN input data on the rising edge of SCLK.

### 8.3.1.5 Data Output (DOUT)

DOUT is the data output pin used to read register data out of the DAC. The data are shifted out on the falling edge of SCLK. DOUT enters a 3-state when  $\overline{\text{CS}}$  is high.

#### 8.3.2 SPI Timeout

The DAC has an SPI timeout feature that can be used to recover the SPI port if a possible noise pulse should occur. The noise pulse may lead to a false SCLK detection that <u>can</u> render the DAC serial port unresponsive. The port is recovered by taking  $\overline{CS}$  high but, in applications where  $\overline{CS}$  is tied low, holding SCLK low for 2<sup>18</sup> CLK cycles resets the SPI port automatically. When SCLK is low, the SPI port resets on every 2<sup>18</sup> CLK cycle interval. Holding SCLK high disables the automatic SPI reset.



## 8.4 Programming

#### 8.4.1 Commands

The commands summarized in Table 14 control and configure the DAC1282. The register read and register write commands are two-byte command arguments plus additional data bytes while the reset command is a one-byte command. The DAC1282 serial port chip select (CS) can be taken high or held low between commands but must remain low for the entire command operation.

**Table 14. Command Definitions** 

| COMMAND | TYPE     | DESCRIPTION  | FIRST OPCODE BYTE     | SECOND OPCODE BYTE |
|---------|----------|--|-----------------------|--------------------|
| RREG    | Register | Read nnnn register(s) at address rrrr <sup>(1)</sup> | 0010 rrrr             | 0000 nnnn          |
| WREG    | Register | Write nnnn register(s) at address rrrr               | 0100 rrrr             | 0000 nnnn          |
| RESET   | Control  | Reset the device                                     | 0000 011x (06 or 07h) | _                  |

<sup>(1)</sup> rrrr = Starting read or write register address, nnnn= number of registers to read or write minus 1.

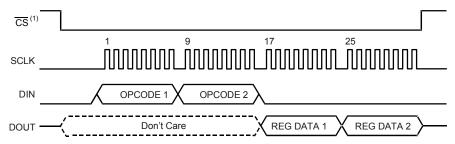
## 8.4.1.1 RREG: Read From Registers

**Description:** These two opcode bytes read register data. The register read operation is a two-byte opcode input followed by one or more bytes of register data as the output. The first byte of the command is the opcode and the register address combined. The second byte of the command specifies the number of registers to read (minus 1) in a block. Register data are output following the command input. Note that for multiple register read operations, the register address pointer does not wrap when the last register is exceeded.

First opcode byte: 0010 rrrr, where rrrr is the starting address register address to be read.

Second opcode byte:  $0000 \, nnnn$ , where nnnn is the number of registers to read -1.

Following bytes: Register data output in MSB-first format. The 16th SCLK falling edge of the opcode clocks out the MSB of the register data.



(1) CS may be tied low.

Figure 48. RREG Command Example: Read Two Registers Starting from Register 00h (Opcode 1 = 0010 0000, Opcode 2 = 0000 0001)



### 8.4.1.2 WREG: Write To Registers

**Description:** These two opcode bytes write register data. The register write operation is a two-byte opcode followed by one or more bytes of register data. The first byte of the command is the write opcode and the register address combined. The second byte of the command specifies the number of registers to write (minus 1) in a single sequence. The following bytes are the register data bytes. Note that for multiple register write operations, the register address pointer does not wrap when the last register is exceeded.

First opcode byte: 0010 *rrrr*, where *rrrr* is the starting address register address to be written.

Second opcode byte:  $0000 \, nnnn$ , where nnnn is the number of registers to write -1.

Following bytes: Register data input in MSB-first format.

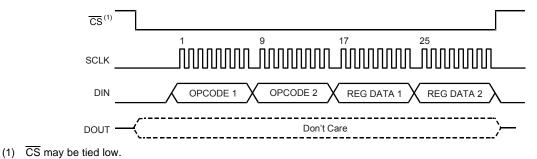


Figure 49. WREG Command Example: Write Two Registers Starting from Register 00h (Opcode 1 = 0100 0000, Opcode 2 = 0000 0001)

### 8.4.1.3 RESET: Device Reset

**Description:** This command resets the DAC. The registers are set to power-on default the value; see the RESET/PWDN section.



# 8.5 Register Map

DAC1282 operation is controlled through a set of 8-bit registers. Collectively, the registers contain all the information needed to configure the DAC, such as output frequency and amplitude, output pulse levels, etc. Table 15 shows the register map.

The default state of the device at power-up, after the RESET pin is taken high or after a RESET command is as follows:

Sine mode, frequency = 31.25 Hz, -36-dB output range, 0-dB digital attenuation Switch state: open

| Table 15. Register Map |
|------------------------|
|------------------------|

| ADDRESS | REGISTER | DEFAULT  | BIT 7  | BIT 6  | BIT 5  | BIT 4  | BIT 3  | BIT 2  | BIT 1  | BIT 0  |
|---------|----------|----------|--------|--------|--------|--------|--------|--------|--------|--------|
| 0       | GANMOD   | xxx11000 | ID2    | ID1    | ID0    | GAIN2  | GAIN1  | GAIN0  | MODE1  | MODE0  |
| 1       | SING     | 00000000 | SINEG7 | SINEG6 | SINEG5 | SINEG4 | SINEG3 | SINEG2 | SINEG1 | SINEG0 |
| 2       | SWM      | 00000000 | FREQ   | SW2    | SW1    | SW0    | M3     | M2     | M1     | MO     |
| 3       | N        | 00000111 | N7     | N6     | N5     | N4     | N3     | N2     | N1     | N0     |
| 4       | DCG0     | 00000000 | DCG7   | DCG6   | DCG5   | DCG4   | DCG3   | DCG2   | DCG1   | DCG0   |
| 5       | DCG1     | 00000000 | DCG15  | DCG14  | DCG13  | DCG12  | DCG11  | DCG10  | DCG9   | DCG8   |
| 6       | DCG2     | 00000000 | DCG23  | DCG22  | DCG21  | DCG20  | DCG19  | DCG18  | DCG17  | DCG16  |
| 7       | PULSA    | 00000000 | 0      | 0      | 0      | PULSA4 | PULSA3 | PULSA2 | PULSA1 | PULSA0 |
| 8       | PULSB    | 00000000 | 0      | 0      | 0      | PULSB4 | PULSB3 | PULSB2 | PULSB1 | PULSB0 |

## 8.5.1 Register Descriptions

Table 16. GANMOD: Range and Mode Register 0 (address = 0h)

| 7   | 6   | 5   | 4     | 3     | 2     | 1     | 0     |
|-----|-----|-----|-------|-------|-------|-------|-------|
| ID2 | ID1 | ID0 | GAIN2 | GAIN1 | GAIN0 | MODE1 | MODE0 |

| Bits[7:5] | ID[2:0]: Factory-programmed ide   | ID[2:0]: Factory-programmed identification bits (read-only) |          |                                    |  |  |  |  |  |
|-----------|---|---|----------|------------------------------------|--|--|--|--|--|
|           | These bits may change at any time   | without notific   | cation.  |                                    |  |  |  |  |  |
| Bits[4:2] | GAIN[2:0]: Analog gain (output range)   |   |          |                                    |  |  |  |  |  |
|           | These bits set the analog gain in the sine, dc, and bitstream modes. The output amplitude is the selected range and the digital gain. Sine mode digital gain is programmed by the SINEG redigital gain are the DCG0, DCG1, and DCG2 registers. Pulse mode levels are exclusively contained PULSB registers. Note that the DAC1282A supports analog gains of 1/1, 1/4, and 1/16 on |   |          |                                    |  |  |  |  |  |
|           | GAIN[2:0]   | DEVIC   | E GAIN   | OUTPUT RANGE<br>(V) <sup>(1)</sup> |  |  |  |  |  |
|           | 000   | 0 dB  | 1/1 V/V  | ±2.5                               |  |  |  |  |  |
|           | 001 (DAC1282 only)  | −6 dB   | 1/2 V/V  | ±1.25                              |  |  |  |  |  |
|           | 010   | -12 dB  | 1/4 V/V  | ±0.625                             |  |  |  |  |  |
|           | 011 (DAC1282 only)  | -18 dB  | 1/8 V/V  | ±0.312                             |  |  |  |  |  |
|           | 100   | -24 dB  | 1/16 V/V | ±0.156                             |  |  |  |  |  |
|           | 101 (DAC1282 only)  | -30 dB  | 1/32 V/V | ±0.078                             |  |  |  |  |  |
|           | 110 (DAC1282 only, default) (2)   | -36 dB  | 1/64 V/V | ±0.039                             |  |  |  |  |  |
| Bits[1:0] | MODE[1:0]: Mode control bits  |   |          |                                    |  |  |  |  |  |
|           | The mode bits set the mode of operation. When the mode bits are changed, the internal signal generator block is reset.  |   |          |                                    |  |  |  |  |  |
|           | 00 = Sine mode (default) 01 = DC mode 10 = Digital data mode 11 = Pulse mode  |   |          |                                    |  |  |  |  |  |

(Peak-to-peak) full-scale output range,  $V_{REF} = 5 \text{ V}$ . Digital gain = 0 dB. Although both devices deafult to GAIN[2:0] = 110, the DAC1282A setting must be changed to one of the supported analog gains listed.



# Table 17. SINEG: Sine Mode Digital Gain Register (address = 01h)

| 7      | 6      | 5      | 4      | 3      | 2      | 1      | 0      |
|--------|--------|--------|--------|--------|--------|--------|--------|
| SINEG7 | SINEG6 | SINEG5 | SINEG4 | SINEG3 | SINEG2 | SINEG1 | SINEG0 |

Bits[7:0] SINEG[7:0]: Sine mode digital gain

This register byte sets the sine mode digital gain from 0 dB to -119.5 dB and to full mute, in 0.5-dB steps.

The sine mode digital gain can be expressed as: -DGAIN[7:0]/2 (dB) and are listed in Table 18.

# Table 18. Sine Mode Digital Gain

| SINE MODE DIGITAL GAIN (dB) |
|-----------------------------|
| 0.0                         |
| -0.5                        |
| -1.0                        |
|                             |
| -119.5                      |
| Full mute                   |
| Full mute                   |
| Full mute                   |
|                             |

# Table 19. SWM: Switch, Output Frequency 'M', And Range Bit Register (address = 02h)

|      |     |     |     |    |    | •  |    |
|------|-----|-----|-----|----|----|----|----|
| 7    | 6   | 5   | 4   | 3  | 2  | 1  | 0  |
| FREQ | SW2 | SW1 | SW0 | M3 | M2 | M1 | MO |

| Bit 7     | FREQ: Frequency  | ,                     |                                     |  |  |  |  |  |
|-----------|--|-----------------------|-------------------------------------|--|--|--|--|--|
|           | This bit sets the sine mode output frequency range; see Equation 1.  |                       |                                     |  |  |  |  |  |
| Bits[6:4] | SW[2:0]: Switch control bits   |                       |                                     |  |  |  |  |  |
|           | These bits control the switch settings when the SW/TD input is high. When SW/TD is low, the register is ignored and the switch is forced open. In digital input mode, the switch is controlled only by the register. |                       |                                     |  |  |  |  |  |
|           | SW[2:0]  | SWITCH DESCRIPTION    | TERMINAL CONNECTIONS                |  |  |  |  |  |
|           | 000  | Open (default)        | All switches open                   |  |  |  |  |  |
|           | 001  | Differential          | SWINP to SWOUTP and SWINN to SWOUTN |  |  |  |  |  |
|           | 010  | Differential reverse  | SWINP to SWOUTN and SWINN to SWOUTP |  |  |  |  |  |
|           | 011  | Common-mode positive  | SWINP to SWOUTP and SWINP to SWOUTN |  |  |  |  |  |
|           | 100  | Common-mode negative  | SWINN to SWOUTP and SWINN to SWOUTN |  |  |  |  |  |
|           | 101  | Single-ended positive | SWINP to SWOUTP only                |  |  |  |  |  |
|           | 110  | Single-ended negative | SWINN to SWOUTN only                |  |  |  |  |  |
|           | 111 Short SWOUTP to SWOUTN   |                       |                                     |  |  |  |  |  |
| Bits[3:0] | M[3:0]: Sine mode  | e frequency, M bits   |                                     |  |  |  |  |  |
|           | These bits control the sine-mode output frequency. The output frequency is given in Equation 1.  |                       |                                     |  |  |  |  |  |



### Table 20. N: Sine Frequency N Register (address = 03h)

|    |    |    |    | , , |    | ,  |    |
|----|----|----|----|-----|----|----|----|
| 7  | 6  | 5  | 4  | 3   | 2  | 1  | 0  |
| N7 | N6 | N5 | N4 | N3  | N2 | N1 | N0 |

Bits[7:0] N[7:0]: N register

These bits control the output frequency; see Equation 1.

#### Table 21. DCG0: DC Mode Digital Gain Byte 0, Least Significant Byte (address = 04h)

| 7    | 6    | 5    | 4    | 3    | 2    | 1    | 0    |
|------|------|------|------|------|------|------|------|
| DCG7 | DCG6 | DCG5 | DCG4 | DCG3 | DCG2 | DCG1 | DCG0 |

# Table 22. DCG1: DC Mode Digital Gain Byte 1, Mid Byte (address = 05h)

| 7     | 6     | 5     | 4     | 3     | 2     | 1    | 0    |
|-------|-------|-------|-------|-------|-------|------|------|
| DCG15 | DCG14 | DCG13 | DCG12 | DCG11 | DCG10 | DCG9 | DCG8 |

## Table 23. DCG2: DC Mode Digital Gain Byte 2, Most Significant Byte (address = 06h)

| 7     | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
|-------|-------|-------|-------|-------|-------|-------|-------|
| DCG23 | DCG22 | DCG21 | DCG20 | DCG19 | DCG18 | DCG17 | DCG16 |

Bits[7:0] DCG[23:0]: DC mode digital gain setting

The DCG0, DCG1, and DCG2 register bytes set the digital gain in dc mode; see Table 5.

## Table 24. PULSA: Pulse Level A Byte (address = 07h)

| 7 | 6 | 5 | 4      | 3      | 2      | 1      | 0      |
|---|---|---|--------|--------|--------|--------|--------|
| 0 | 0 | 0 | PULSA4 | PULSA3 | PULSA2 | PULSA1 | PULSA0 |

Bits[7:5]

Reserved
Always write '0'.

Bits[4:0]

PULSA[4:0]: Pulse level A bits
These bits create pulse level A. (Selected output when SYNC is low.)

The PULSA and PULSB registers set two independent levels that can be used to provide pulse output. The

The PULSA and PULSB registers set two independent levels that can be used to provide pulse output. The SYNC pin selects either level PULSA or level PULSB as the DAC output. The pulse amplitude resolution is programmable in discrete steps, as shown in Table 6. Note that the pulse level value is independent of the RANGE[2:0] setting.

## Table 25. PULSB: Pulse Level B Byte (address = 08h)

| 7 | 6 | 5 | 4      | 3      | 2      | 1      | 0      |
|---|---|---|--------|--------|--------|--------|--------|
| 0 | 0 | 0 | PULSB4 | PULSB3 | PULSB2 | PULSB1 | PULSB0 |

| Bits[7:5] | Reserved  |
|-----------|---|
|           | Always write '0'.   |
| Bits[4:0] | PULSB[4:0]: Pulse level B bits  |
|           | These bits create pulse level B.  |
|           | The PULSA and PULSB registers set two independent levels that can be used to provide pulse output. The SYNC pin selects either level PULSA or level PULSB as the DAC output. The pulse amplitude resolution is programmable in discrete steps; see Table 6. Note that the pulse level value is independent of the RANGE[2:0] setting. |



# 9 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

# 9.1 Application Information

Figure 50 shows the basic DAC1282 connection. Bipolar analog supplies are shown ( $\pm 2.5$  V). Single-supply operation is also possible with AVDD = 5 V and AVSS = GND. The digital supply range is 1.65 V to 3.6 V.

A low-noise, low-drift reference is recommended for best performance, such as the REF5050 (+5 V) and REF5045 (+4.5 V). Best signal-to-noise ratio is achieved with a 5-V reference, although a 4.5-V reference (REF5045) can be used with 1-dB loss in SNR. The 4.5-V reference can be operated from a 5-V supply. AVSS (pin 14) is the key reference ground point and should be connected to the reference ground terminal using a star connection.  $C_1$  and  $C_2$  are the required 1-nF output filter capacitors. The capacitors should be of the low volt-coefficient type (such as a COG ceramic or similar) and placed close to the device pins. Output resistors,  $R_1$  and  $R_2$ , decouple the DAC to ensure best performance when driving capacitive loads. The output is shown routed to the signal switch, providing a second, switched DAC output.

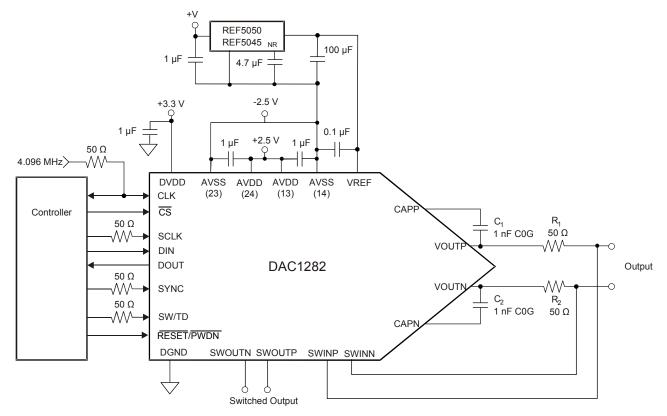


Figure 50. Basic Connection



### 9.2 Typical Applications

### 9.2.1 Single-Channel Seismic System

Figure 51 illustrates a single-channel data acquisition concept for seismic. The DAC1282 is used to test both the ADC and geophone. The DAC1282 connects directly to channel 1 of the ADC. Tests of the ADC include THD, pulse, input noise, common-mode, etc. The DAC output and ADC sample timing are controlled by the SYNC input pins.

The geophone connects to channel 2 of the ADC through input protection and optional filter networks. The DAC connects to the geophone using the integrated signal switch. Series resistors isolate the geophone from the DAC output. Geophone test capabilities include impulse, THD, leakage, and common-mode.

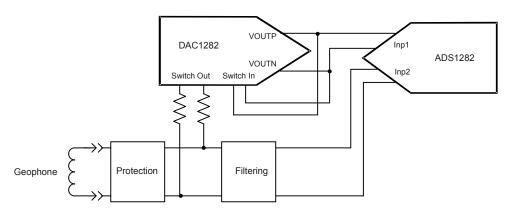


Figure 51. Single-Channel Seismic System

Product Folder Links: DAC1282



## **Typical Applications (continued)**

### 9.2.2 Four-Channel Seismic System

Figure 52 illustrates a four-channel system. The switched DAC1282 output is routed to the ADC inputs. The signal from the DAC switch is used to perform sensor impulse testing by opening the switch while digitizing the response.

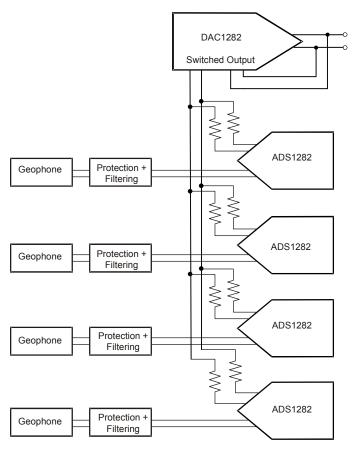


Figure 52. Four-Channel Seismic System

Product Folder Links: DAC1282



## 10 Device and Documentation Support

### 10.1 Community Resources

The following links connect to TI community resources. Linked contents are provided AS IS by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 10.2 Trademarks

E2E is a trademark of Texas Instruments.

SPI is a trademark of Motorola.

All other trademarks are the property of their respective owners.

### 10.3 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 10.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: DAC1282

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#### PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package   Pins  | Package qty   Carrier | RoHS | Lead finish/  | MSL rating/         | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|-----------------|-----------------------|------|---------------|---------------------|--------------|--------------|
|                       | (1)    | (2)           |                 |                       | (3)  | Ball material | Peak reflow         |              | (6)          |
|                       |        |               |                 |                       |      | (4)           | (5)                 |              |              |
| DAC1282AIPW           | Active | Production    | TSSOP (PW)   24 | 60   TUBE             | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282A     |
| DAC1282AIPW.A         | Active | Production    | TSSOP (PW)   24 | 60   TUBE             | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282A     |
| DAC1282AIPWR          | Active | Production    | TSSOP (PW)   24 | 2000   LARGE T&R      | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282A     |
| DAC1282AIPWR.A        | Active | Production    | TSSOP (PW)   24 | 2000   LARGE T&R      | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282A     |
| DAC1282IPW            | Active | Production    | TSSOP (PW)   24 | 60   TUBE             | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282      |
| DAC1282IPW.A          | Active | Production    | TSSOP (PW)   24 | 60   TUBE             | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282      |
| DAC1282IPWR           | Active | Production    | TSSOP (PW)   24 | 2000   LARGE T&R      | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282      |
| DAC1282IPWR.A         | Active | Production    | TSSOP (PW)   24 | 2000   LARGE T&R      | Yes  | NIPDAU        | Level-2-260C-1 YEAR | -40 to 85    | DAC1282      |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE OPTION ADDENDUM**

www.ti.com 23-May-2025

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## **PACKAGE MATERIALS INFORMATION**

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### TAPE AND REEL INFORMATION





|    | •   |
|----|---|
| A0 | Dimension designed to accommodate the component width     |
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

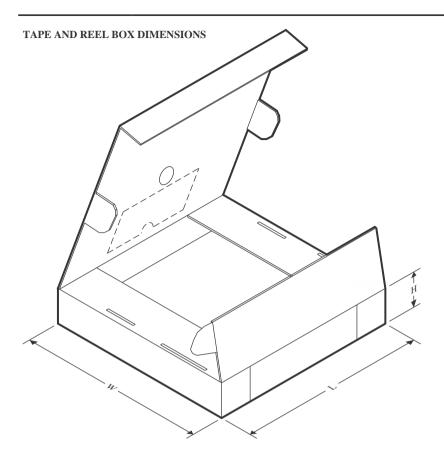
### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device       | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| DAC1282AIPWR | TSSOP           | PW                 | 24 | 2000 | 330.0                    | 16.4                     | 6.95       | 8.3        | 1.6        | 8.0        | 16.0      | Q1               |
| DAC1282IPWR  | TSSOP           | PW                 | 24 | 2000 | 330.0                    | 16.4                     | 6.95       | 8.3        | 1.6        | 8.0        | 16.0      | Q1               |

www.ti.com 23-May-2025



### \*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins SPQ |      | Length (mm) | Width (mm) | Height (mm) |  |
|--------------|--------------|-----------------|----------|------|-------------|------------|-------------|--|
| DAC1282AIPWR | TSSOP        | PW              | 24       | 2000 | 350.0       | 350.0      | 43.0        |  |
| DAC1282IPWR  | TSSOP        | PW              | 24       | 2000 | 350.0       | 350.0      | 43.0        |  |

# **PACKAGE MATERIALS INFORMATION**

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### **TUBE**



\*All dimensions are nominal

| Device        | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|---------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| DAC1282AIPW   | PW           | TSSOP        | 24   | 60  | 530    | 10.2   | 3600   | 3.5    |
| DAC1282AIPW.A | PW           | TSSOP        | 24   | 60  | 530    | 10.2   | 3600   | 3.5    |
| DAC1282IPW    | PW           | TSSOP        | 24   | 60  | 530    | 10.2   | 3600   | 3.5    |
| DAC1282IPW.A  | PW           | TSSOP        | 24   | 60  | 530    | 10.2   | 3600   | 3.5    |



SMALL OUTLINE PACKAGE



### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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